Application/Control No.	Applicant(s)/Patent under Reexamination
10/774,212	HSIEH ET AL.
Examiner	Art Unit

Matthew E. Warren

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	SEARCHED				
Class	Subclass	Date	Examiner		
257	329-331 333*, 335 E29.262- 265	4/20/2005	MEW		
257	E29.257	4/20/2005	MEW		
438	259, 270	4/23/2005	MEW		
438	271, 589	4/23/2005	MEW		
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
Text Search		4/21/2005	MEW